Search Notes			

Application/Control No.	Applicant(s)/Patent un Reexamination	der
10/659,213	MIYA ET AL.	
Examiner	Art Unit	
Jason Heckert	1746	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH I (INCLUDING SEAR)
	DATE	EXMR
Updated EAST Search	2/7/2007	·
Consulted Joe Perrin	2/7/07	
Consulted Mike Barr	2/8/2007	
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